

Form PTO-1449

Attorney Docket No.
62004-1950Serial No.
09/995,161

INFORMATION DISCLOSURE CITATION

Applicant **Dalmia, et al.**

(Use several sheets if necessary)

Filing Date **11/26/01**Group **2811**

U.S. PATENT DOCUMENTS

Examiner Initials	Item	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TTN	A	5,106,461	4 21 92	Volfson, et al.	205	125	
	B	5,247,377	9 21 93	Omeis, et al.	359	76	
	C	5,323,128	6 21 94	Ishizaki, et al.	333	204	
	D	5,349,314	9 20 94	Shimizu, et al.	333	204	
	E	5,373,271	12 13 94	Hirai, et al.	333	205	
	F	5,396,201	5 7 95	Ishizaki, et al.	333	204	
	G	5,416,454	5 16 95	McVeety	333	204	
	H	5,497,337	3 5 96	Ponnapalli, et al.	364	489	
	I	5,517,751	5 21 96	Bross, et al.	29	830	
TTN	J	5,545,916	8 13 96	Koullias	257	531	

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
TTN	K	WO 01 97582 A1	12 20 01	Japan				X
TTN	L	EP 0 506 476 B1	3 27 92	Great Britain			X	
TTN	M	EP 0 510 971 B1	4 23 92	Great Britain			X	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

TTN	N	Loke, et al., "Evaluation of Copper Penetration in Low-Polymer Dielectrics by Bias-Temperature Stress," 1999 MRS Spring Meeting, Symposium N O. Paper 04.4 Preprint, San Francisco, CA 4/7/99.						
TTN	O	NASA SBIR Successes," http://sbir.gsfc.nasa.gov/SBIR/successes/Stratasoft/110text.html NO DATE						
	P	Flexible Printed Circuit - YFLEX," http://www.yamaichi.us/yflex.html NO DATE						
TTN	Q	Wang, et al., "A Full-Wave Analysis Model for Uniplanar Circuits with Lumped Elements," IEEE Transactions of Microwave Theory and Techniques, Vol. 51, No. 1 January 2003.						

* EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

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Examiner Initials	Item	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TTN	R	5,559,360	9 24 96	Chiu, et al.	257	531	
	S	5,635,892	6 3 97	Ashby, et al.	336	200	
	T	5,654,681	8 5 97	Ishizaki, et al.	333	204	
	U	5,668,511	9 16 97	Furutani, et al.	333	204	
	V	5,679,414	10 21 97	Akashi, et al.	428	1	
	W	5,716,663	2 10 98	Capote, et al.	427	96	
	X	5,719,354	2 17 98	Jester, et al.	174	255	
	Y	5,719,539	2 17 98	Ishizaki, et al.	333	204	
	Z	5,720,898	2 24 98	Nohira, et al.	252	299.01	
TTN	AA	5,770,986	6 23 98	Tonegawa, et al.	333	204	

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Examiner Initials	Item	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TTN	BB	5,801,100	9-1-98	Lee, et al.	438	678	
	CC	5,818,313	10-6-98	Estes, et al.	333	262	
	DD	5,844,299	12-1-98	Merrill, et al.	257	531	
	EE	5,917,244	6-29-99	Lee, et al.	257	762	
	FF	5,999,243	12-7-99	Kameyama, et al.	349	185	
	GG	6,008,102	12-28-99	Alford, et al.	438	381	
	HH	6,026,286	2-15-00	Long	455	327	
	II	6,040,226	3-21-00	Wojnarowski, et al.	438	381	
	JJ	6,051,289	4-18-00	Tsujimoto, et al.	428	1	
TTN	KK	6,093,599	7-25-00	Lee, et al.	438	238	

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Examiner Initials	Item	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TTN	LL	6,114,925	9 5 00	Lo	333	185	
	MM	6,127,905	10 3 00	Horie	333	204	
	NN	6,166,799	12 26 00	Kameyama, et al.	349	185	
	OO	6,177,853	1 23 01	Nagatomi, et al.	333	204	
	PP	6,191,666	2 20 01	Sheen	333	185	
	QQ	6,191,669	2 20 01	Shigemura	333	204	
	RR	6,225,696	5 1 01	Hathaway, et al.	257	728	
	SS	6,255,714	7 3 01	Kossives, et al.	257	528	
	TT	6,259,148	7 10 01	Barush, et al.	257	531	
TTN	UU	6,261,872	7 17 01	Hathaway, et al.	438	126	

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TTN	VV	6,281,430	8/28/01	Lupo, et al.	136	263	
	WW	6,287,931	9/11/01	Chen	438	381	
	XX	6,303,423	10/16/01	Lin	438	238	
	YY	6,395,374	5/28/02	McAndrew, et al.	428	138	
	ZZ	6,445,266	9/3/02	Nagatomi, et al.	333	204	
	AA1	2001/0004228	6/21/01	Hirai, et al.	333	204	12/20/00
	BB1	2001/0050599	12/13/01	Maekawa, et al.	333	134	12/27/00
	CC1	2002/0008301	1/24/02	Liou, et al.	257	531	12/15/98
	DD1	2002/0048930	4/25/02	Lin	438	622	10/9/01
TTN	EE1	2002/0064701	5/30/02	Hand, et al.	429	34	9/11/01

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TTN	FF1	2002 0074158	6 20 02	St. Lawrence, et al.	174	258	12 13 01
	GG1	2002 0064922	5 30 02	Lin	438	381	10 3 01
	HH1	2002 0076538	6 20 02	St. Lawrence, et al.	428	209	12 4 01
	II1	2002 0081433	6 27 02	Connelly, et al.	428	458	6 8 01
TTN	JJ1	2002 0158305	10 31 02	Dalmia, et al.	257	531	11 26 01

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